Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/805,346	WANG ET AL.	
Examiner	Art Unit	
Evan Dzierzynski	2875	

SEARCHED				
Class	Subclass	Date	Examiner	
362	240	4/18/2006	ED	
	555	4/18/2006	ED	
	559	4/18/2006	ED	
	252	4/18/2006	ED	
	545	4/18/2006	ED	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST word search, see attachment	4/18/2006	ED	
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